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## INFORMATION DISCLOSURE STATEMENT BY APPLICANT

Complete if Known TBA Application Number May 31, 2005 Filing Date First Named Inventor Sören DAMBACH TBA Group Art Unit Examiner Name TBA Attorney Docket Number 39129-218718

(use as many sheets as necessary) Sheet 1 of 2

			U.S. PATENT DOCUM	MENTS	
	Cite No.1	U.S. Patent Document	Name of Patentee or Applicant	Date of Publication of Cited Document MM-DD-YYYY 04/27/1999	Pages, Columns, Lines, Where Relevan Passages or Relevant Figures Appear
Examiner Initials		Number Kind Code <sup>2</sup> (if known)	of Cited Document		
/B.L./		5,897,192	Seufert		
1	AB	5,079,544	DeMond et al.	01/07/1992	
	AC	5,552,922	Magarill	09/03/1992	
	AD	5,625,738	Magarill	04/29/1997	
$\top$	AE	5,796,508	Suzuki	08/18/1998	
1	AF	6,422,704	Gyoten, et al	07/23/2002	
1	AG	2002/085288	Dewald,. et al	07/04/2002	
1/	AH	2002/140910	Stark, et al	10/03/2002	
$\mathbf{v}$	AI	2002/005114t	Kito	05/02/2002	

				FORE	IGN PATENT DO	CUMENTS		
Examiner Initials*	Cite No.1	Foreign Patent Document			Name of Patentee	Date of Publication of	Pages, Columns, Lines,	
		Office <sup>3</sup>	Number <sup>4</sup>	Kind Code <sup>5</sup> (if known)	or Applicant of Cited Document	Cited Document MM-DD-YYYY	Where Relevant Passages or Relevant Figures Appear	T <sub>0</sub>
/R'L'/	BA	DE	10103099			08/08/2002		Abstract
1	BB	DE	19819245			06/10/1999		Abstract
	BC	wo	95/11572			10/19/1994		
	BD	DE	19824917			12/09/1999		Abstract
	BE	DE	3586855			04/01/1993		Abstract
	BF	DE	4006189			09/12/1991		Abstract
$\top$	BG	DE	9406273.0			06/09/1994		
	BH	EP	0757278			02/05/1997		
	BI	EP	1178672			02/06/2002		
	BJ	DE	10256503			07/06/2004		Abstract
71	BK	EP	1031874			08/30/2000		Abstract
-	BL	DE	69424858					

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					Application Number	TBA		
				CLOSURE	Filing Date	May 31, 2005		
STATEMENT BY APPLICANT					First Named Inventor	Sören DAMBACH		
					Group Art Unit	TBA		
	1	(use as many she	ets as	necessary)	Examiner Name	ТВА		
$\overline{}$	Sheet	2	of	2	Attorney Docket Number	39129-218718		

OTHER PRIOR ART NON PATENT LITERATURE DOCUMENTS					
Examiner Initials*	Cite No.1	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T²		
/B.L./	CA	Patent Abstracts of Japan, No. 09203690			
/B.L./	СВ	Patent Abstracts of Japan, No. 10090645			
/B.L./	СС	M. R. DOUGLASS, "Lifetime Estimates and Unique Failure Mechanisms of the Digital Micromirror Devise (DMD)", Texas Instruments, Digital Instruments, Plano Texas.			

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